

DOCKET NO: 204612US2



IN THE UNITED STATES PATENT & TRADEMARK OFFICE

IN RE APPLICATION OF :  
YUUICHI HIRANO ET AL. : EXAMINER: TRAN, THIEN F.  
SERIAL NO: 09/802,886 :  
2<sup>ND</sup> RCE FILED: HEREWITH : GROUP ART UNIT: 2811  
FOR: SEMICONDUCTOR DEVICE :

AMENDMENT FILED CONCURRENTLY WITH REQUEST FOR CONTINUED

EXAMINATION (RCE)

COMMISSIONER FOR PATENTS  
ALEXANDRIA, VIRGINIA 22313

SIR:

Prior to a further examination on the merits, please amend the above-identified application as follows:

**Amendments to the Claims** are reflected in the listing of claims which begins on page 2 of this paper.

**Remarks/Arguments** begin on page 5 of this paper.